

Notice of References Cited	Application/Control No. 10/719,546	Applicant(s)/Patent Under Reexamination TAKEDA ET AL.	
	Examiner Thuy V. Tran	Art Unit 2821	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,226,196	05-2001	Toshinari et al.	363/134
*	B	US-6,184,631	02-2001	Noma et al.	315/224
*	C	US-6,153,962	11-2000	Noma et al.	310/316.01
*	D	US-6,118,221	09-2000	Kumasaka et al.	315/209PZ
*	E	US-6,028,398	02-2000	Kawasaki et al.	315/224
*	F	US-5,942,835	08-1999	Furuhashi et al.	310/316.01
*	G	US-5,923,546	07-1999	Shimada et al.	363/40
*	H	US-5,886,477	03-1999	Honbo et al.	315/209PZ
*	I	US-5,866,969	02-1999	Shimada et al.	310/318
*	J	US-5,859,489	01-1999	Shimada, Yasuhei	310/318
*	K	US-5,705,877	01-1998	Shimada, Yasuhei	310/318
*	L	US-5,675,484	10-1997	Shimada, Yasuhei	363/71
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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